

1. Description

The HS7N60 N-Channel enhancement mode silicon gate power MOSFET is designed for high voltage, high speed power switching applications such as switching regulators, switching converters, solenoid, motor drivers, relay drivers.

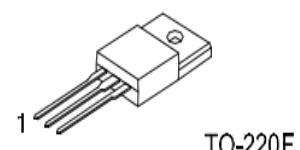
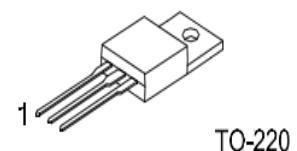
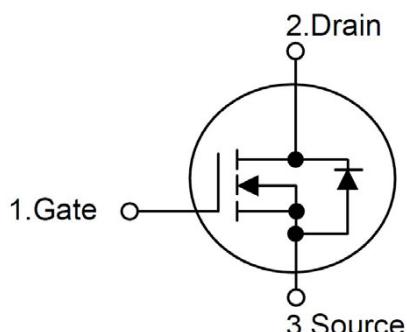
2. Feature

- $R_{DS(ON)}$ MAX = 1.2Ω @ $V_{GS}=10\text{ V}$
- Low gate charge (typical 28nC)
- Fast switching capability
- Avalanche energy specified
- Improved dv/dt capability

V_{DS}	600	V
$R_{DS(ON)}$	1.2	Ω
I_D	7	A

3. Pin configuration

Package	Order Number
TO-220F	HS7N60FA
TO-220	HS7N60PA



4. Absolute maximum ratings (TC= 25 °C, unless otherwise specified)

Parameter	Symbol	Ratings	Units
Drain-source voltage	V _{DSS}	600	V
Gate-source voltage	V _{GSS}	±30	V
Drain current continuous T _c =25°C T _c =100°C	I _D	7.0	A
		5.1	A
Drain current pulsed (note1)	I _{DP}	29	A
Avalanche energy	EAR	27.9	mJ
	EAS	270	mJ
Peak diode recovery dv/dt (note3)	dv/dt	4.5	V/ns
Total power dissipation	P _D	145	W
		1.15	W/°C
Junction temperature	T _J	+150	°C
Storage temperature	T _{TSG}	-55~+150	°C

5. Thermal characteristics (note6)

Parameter	Symbol	Ratings		Units
		TO-220	TO-220F	
Thermal resistance junction-ambient	R _{thJA}	62.5		°C/W
Thermal resistance, case-to-sink typ	R _{thCS}	0.7	--	
Thermal resistance junction-case	R _{thJC}	1.2	2.7	

6. Electrical characteristics ($T_C = 25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Test conditions	Min	Typ	Max	Unit
Off characteristics						
Drain-source breakdown voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	600	-	-	V
Zero gate voltage drain current	I_{DSS}	$V_{\text{DS}}=600\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
		$V_{\text{DS}}=480\text{V}, T_C=125^\circ\text{C}$	-	-	10	μA
Gate-body leakage current	I_{GSS}	$V_{\text{GS}}=30\text{V}, V_{\text{DS}}=0\text{V}$	-	-	100	nA
		$V_{\text{GS}}=-30\text{V}, V_{\text{DS}}=0\text{V}$	-	-	-100	nA
Breakdown voltage temperature coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	$I_{\text{D}}=250\mu\text{A}$	-	0.7	-	V/ $^\circ\text{C}$
On characteristics						
Gate threshold voltage	$V_{\text{GS(TH)}}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.0	-	4.0	V
Static drain-source on- resistance	$R_{\text{DS(ON)}}$	$V_{\text{DS}}=10\text{V}, I_{\text{D}}=3.5\text{A}$	-	1.0	1.2	Ω
Dynamic characteristics						
Input capacitance	C_{ISS}	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	980	-	pF
Output capacitance	C_{OSS}		-	105	-	pF
Reverse transfer capacitance	C_{RSS}		-	5	-	pF
Switching characteristics						
Turn-on delay time	$t_{\text{D(ON)}}$	$V_{\text{DD}}=300\text{V}, I_{\text{D}}=7.0\text{A}, R_G=25\Omega$ (note4,5)	-	10	-	ns
Rise time	t_R		-	35	-	ns
Turn-off delay time	$t_{\text{D(OFF)}}$		-	35	-	ns
Fall time	t_F		-	40	-	ns
Total gate charge	Q_G	$V_{\text{DS}}=480\text{V}, I_{\text{D}}=7.0\text{A}$ $V_{\text{GS}}=10\text{V}$ (note4,5)	-	35	-	nC
Gate-source charge	Q_{GS}		-	5.5.	-	nC
Gate-drain charge	Q_{GD}		-	20	-	nC
Drain-source diode characteristics						
drain-source diode forward voltage	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{SD}}=7.0\text{A}$	-	-	1.4	V
Continuous drain-source current	I_{SD}		-	-	7.0	A
Pulsed drain-source current	I_{SM}		-	-	28	A
Reverse recovery time	t_{RR}	$I_{\text{SD}}=7.0\text{A}$ $dI_{\text{SD}}/dt=100\text{A}/\mu\text{s}$ (note4)	-	270	-	ns
Reverse recovery charge	Q_{RR}		-	2.3	-	μC

- Note : 1. Repetitive rating : pulse width limited by maximum junction temperature
2. $L=25\text{mH}, I_{\text{AS}} = 7.0\text{ A}, V_{\text{DD}} = 50\text{V}, R_G = 25 \Omega$, starting $T_J = 25^\circ\text{C}$
 3. $I_{\text{SD}} \leq 7.0\text{A}, di/dt \leq 200\text{A}/\mu\text{s}, V_{\text{DD}} \leq \text{BV}_{\text{DSS}}$, starting $T_J = 25^\circ\text{C}$
 4. Pulse test : pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
 5. Essentially independent of operating temperature
 6. Thermal characteristics are reported for the TO-220 package